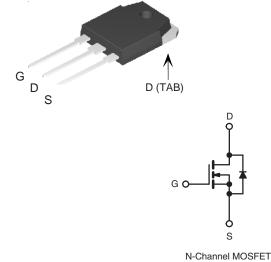


N-Channel 500V(D-S) Super Junction Power MOSFET

PRODUCT SUMMARY						
V _{DS} (V) at T _J max.	500					
R _{DS(on)} at 25 °C (Ω)	$V_{GS} = 10 V$	0.050				
Q _g max. (nC)	263					
Q _{gs} (nC)	41					
Q _{gd} (nC)	72					
Configuration	Single					





FEATURES

- Low figure-of-merit (FOM) Ron x Qg
- Low input capacitance (Ciss)
- Reduced switching and conduction losses
- Ultra low gate charge (Qg)
- Avalanche energy rated (UIS)

APPLICATIONS

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
 - High-intensity discharge (HID)
 - Fluorescent ballast lighting
- Industrial
 - Welding
 - Induction heating
 - Motor drives
 - Battery chargers
 - Renewable energy
 - Solar (PV inverters)

ABSOLUTE MAXIMUM RATINGS ($T_C = 25 \text{ °C}$, unless otherwise noted)										
PARAMETER			SYMBOL	LIMIT	UNIT					
Drain-Source Voltage			V _{DS}	500	V					
Gate-Source Voltage			V _{GS}	± 30	v					
Continuous Drain Current (T _J = 150 °C)	V _{GS} at 10 V	$T_{\rm C} = 25 \ ^{\circ}{\rm C}$ $T_{\rm C} = 100 \ ^{\circ}{\rm C}$	- I _D	47						
	V _{GS} at 10 V	T _C = 100 °C		30	А					
Pulsed Drain Current ^a			I _{DM}	139						
Linear Derating Factor				3.3	W/°C					
Single Pulse Avalanche Energy ^b			E _{AS}	1410	mJ					
Maximum Power Dissipation			PD	387	W					
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +150	°C					
Drain-Source Voltage Slope	T _J = 125 °C		-1) (/ -1+	37						
Reverse Diode dV/dt ^d			dV/dt	9	V/ns					
Soldering Recommendations (Peak Temperature) ^c	for 10 s			300	°C					

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature.

b. V_{DD} = 50 V, starting T_J = 25 °C, L = 28.2 mH, R_g = 25 $\Omega,\,I_{AS}$ = 10 A.

c. 1.6 mm from case.

d. $I_{SD} \leq I_D, \, dI/dt$ = 100 A/µs, starting T_J = 25 °C.





PARAMETER	SYMBOL	TYP.	MAX.			UNIT		
Maximum Junction-to-Ambient	R _{thJA}	- 40 - 0.3			- °C/W			
Maximum Junction-to-Case (Drain)	R _{thJC}							
		1						
SPECIFICATIONS (T _J = 25 °C, u	inless otherw	ise noted)						
PARAMETER	SYMBOL		T CONDITIONS	MIN.	TYP.	MAX.	UNI	
Static							••••	
Drain-Source Breakdown Voltage	V _{DS}	V _{CS} :	= 0 V, I _D = 250 μA	500	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference to 25 °C, $I_D = 1 \text{ mA}$		-	0.70	-	V/°C	
Gate-Source Threshold Voltage (N)	V _{GS(th)}		$V_{DS} = V_{GS}, I_D = 250 \mu A$		-	4	V	
	- 63(11)	$V_{GS} = \pm 20 V$ $V_{GS} = \pm 30 V$		2	-	± 100	nA	
Gate-Source Leakage	I _{GSS}			-	-	± 1	μA	
Zero Gate Voltage Drain Current			= 500 V, V _{GS} = 0 V	-	-	1	P" 1	
	I _{DSS}	-	$V_{\rm r}, V_{\rm GS} = 0 \text{ V}, \text{ T}_{\rm J} = 125 \text{ °C}$	-	-	25	μA	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V		-	0.050	-	Ω	
Forward Transconductance	9 _{fs}	V _{DS}	= 30 V, I _D = 24 A	-	16.7	-	S	
Dynamic		-		÷	•	•	•	
Input Capacitance	C _{iss}	$V_{GS} = 0 V,$ $V_{DS} = 100 V,$ f = 1 MHz $V_{DS} = 0 V \text{ to } 400 V, V_{GS} = 0 V$		-	5182	-	pF	
Output Capacitance	C _{oss}			-	251	-		
Reverse Transfer Capacitance	C _{rss}			-	1	-		
Effective Output Capacitance, Energy Related ^a	C _{o(er)}			-	192	-		
Effective Output Capacitance, Time Related ^b	C _{o(tr)}			-	665	-		
Total Gate Charge	Qg	$V_{GS} = 10 \text{ V}$ $I_D = 24 \text{ A}, \text{ V}_{DS} = 400 \text{ V}$		-	172	263	nC	
Gate-Source Charge	Q _{gs}			-	41	-		
Gate-Drain Charge	Q _{gd}			-	72	-		
Turn-On Delay Time	t _{d(on)}	$V_{DD} = 400 \text{ V}, \text{ I}_{D} = 6 \text{ A},$ $V_{GS} = 10 \text{ V}, \text{ R}_{g} = 9.1 \Omega$		-	37	84	- ns	
Rise Time	t _r			-	77	121		
Turn-Off Delay Time	t _{d(off)}			-	156	234		
Fall Time	t _f			-	93	196		
Gate Input Resistance	R _g	f = 1 MHz, open drain		-	0.64	-	Ω	
Drain-Source Body Diode Characteristi	cs							
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	47	A	
Pulsed Diode Forward Current	I _{SM}			-	-	139		
Diode Forward Voltage	V _{SD}	T _J = 25 °C, I _S = 24 A, V _{GS} = 0 V		_	0.9	1.2	v	
Reverse Recovery Time	t _{rr}	$T_{J} = 25 \text{ °C}, I_{F} = I_{S} = 24 \text{ A},$ $dI/dt = 100 \text{ A}/\mu\text{s}, V_{R} = 25 \text{ V}$		-	753	1506	ns	
Reverse Recovery Charge	Q _{rr}			-	14	28	μC	
Reverse Recovery Current	I _{RRM}			-	28	-	A	

Notes

a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} . b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .



TYPCIAL CHARACTERISTICS (25 °C, unless otherwise noted)

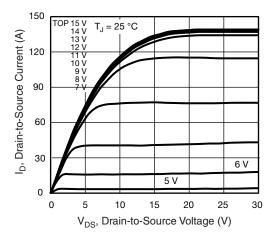


Fig. 1 - Typical Output Characteristics

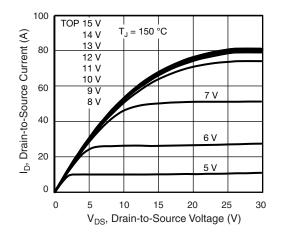


Fig. 2 - Typical Output Characteristics

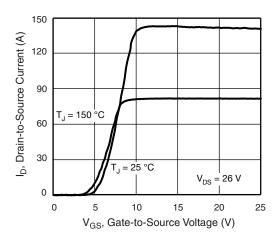


Fig. 3 - Typical Transfer Characteristics

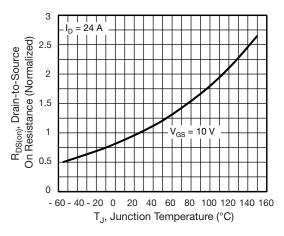


Fig. 4 - Normalized On-Resistance vs. Temperature

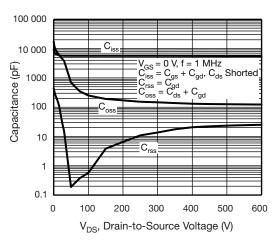


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

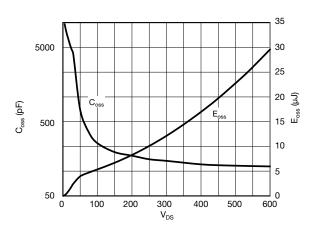


Fig. 6 - Coss and Eoss vs. VDS

VBPB15R47S

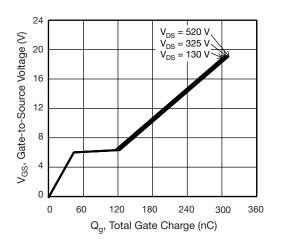


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

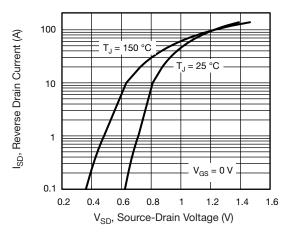


Fig. 8 - Typical Source-Drain Diode Forward Voltage

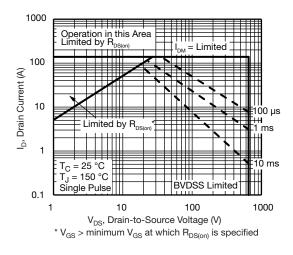
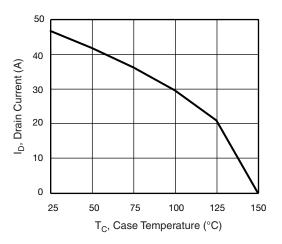


Fig. 9 - Maximum Safe Operating Area



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Fig. 10 - Maximum Drain Current vs. Case Temperature

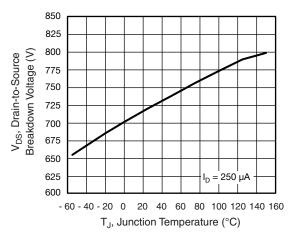


Fig. 11 - Temperature vs. Drain-to-Source Voltage

VBPB15R47S

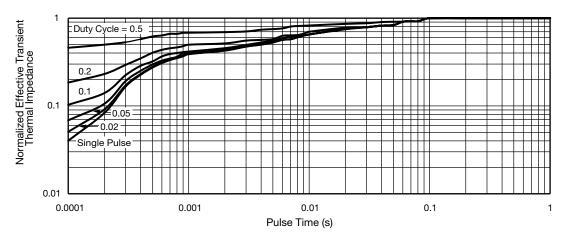


Fig. 12 - Normalized Thermal Transient Impedance, Junction-to-Case

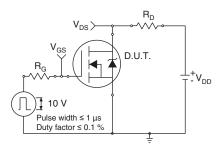


Fig. 13 - Switching Time Test Circuit

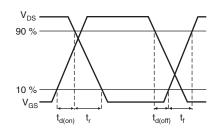


Fig. 14 - Switching Time Waveforms

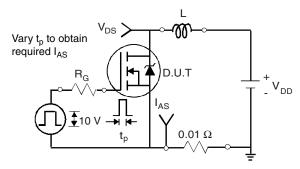


Fig. 15 - Unclamped Inductive Test Circuit

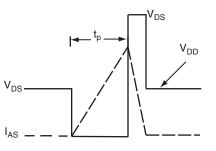


Fig. 16 - Unclamped Inductive Waveforms

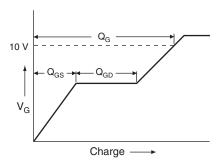


Fig. 17 - Basic Gate Charge Waveform

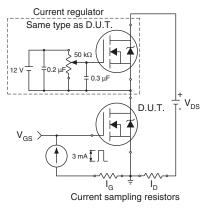


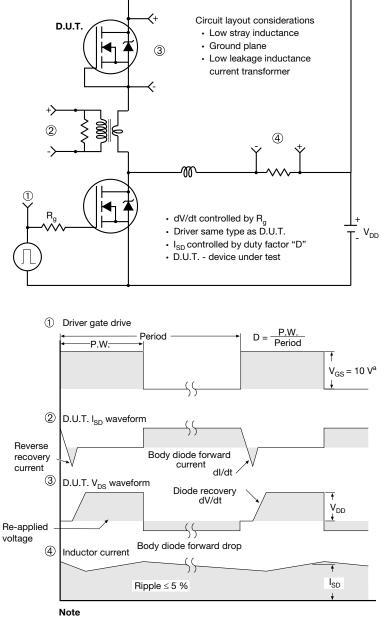
Fig. 18 - Gate Charge Test Circuit

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Peak Diode Recovery dV/dt Test Circuit



a. $V_{GS} = 5 V$ for logic level devices

Fig. 19 - For N-Channel



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